

Notice of References Cited	Application/Control No. 10/631,784	Applicant(s)/Patent Under Reexamination YAMADA, AKIHIRO	
	Examiner Allen H. Nguyen	Art Unit 2625	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,886,028	04-2005	Matsuyama et al.	709/203
*	B	US-7,173,718	02-2007	Iwata et al.	358/1.13
*	C	US-7,145,673	12-2006	Lin, Alan	358/1.15
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
	Q					
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NON-PATENT DOCUMENTS

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	V	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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